

Magnetically induced spin-dependent photoemission from p -GaAs(Cs,O) into vacuum

D. A. Orlov

*Institute of Semiconductor Physics, Russian Academy of Sciences, 630090, Novosibirsk, Russia,
and Max-Planck Institut für Kernphysik, D-69117 Heidelberg, Germany*

V. L. Alperovich* and A. S. Terekhov

*Institute of Semiconductor Physics, Russian Academy of Sciences,
and Novosibirsk State University, 630090, Novosibirsk, Russia*

(Dated: May 24, 2008)

A spin-dependent emission of optically oriented electrons from p -GaAs(Cs,O) into vacuum was experimentally observed in a magnetic field normal to the surface. This phenomenon is explained within the model which takes into account the jump in the electron g factor at the semiconductor-vacuum interface. Due to this jump, the effective electron affinity on the semiconductor surface depends on the mutual direction of optically oriented electron spins and the magnetic field, resulting in the spin-dependent photoemission. It is demonstrated that the observed effect can be used for the determination of spin diffusion length in semiconductors.

PACS numbers: 72.25.Fe, 72.25.Mk, 78.20.Ls, 79.60.Dp

I. INTRODUCTION

Investigations of spin-polarized electron transport through various interfaces in solid-state structures constitute an important domain of spintronics and have been an area of active research for over ten years.¹ In this context, studies of the emission process of optically oriented electrons from semiconductors with the state of effective negative electron affinity² (NEA) are of both applied and fundamental interest. The application prospects are related to the development of spin detectors for low energy electron beams^{3,4} and of efficient spin-polarized electron sources.^{5,6} The scientific interest lies in the elucidation of mechanisms of spin relaxation during transport through a semiconductor-vacuum interface. It is also important that this interface can be considered as a model one at which the energy, effective mass and g factor undergo jumps at ultimately small distances of about an interatomic separation. In contrast to the solid-state heterojunctions, in vacuum it is possible to measure not only a total electric current through the interface but also the energy and momentum distributions of emitted electrons^{7,8,9} and their spin.¹⁰ These investigations enable one to clarify the conditions and restrictions for the use of effective electron parameters, such as the effective mass and the effective g factor, for the description of charge and spin transfer through abrupt interfaces. Measurements of photoemission with angular and spin resolution open the possibility of studying spin-dependent tunneling of electrons that was predicted in Refs. 11,12,13.

Spin-dependent electron transport, which is caused by the jump in the electron g factor at internal semiconductor interfaces, was previously studied in Refs. 14 and 15. Gruber et al.¹⁴ investigated spin-dependent resonant electron tunneling through the Zeeman levels of a double-barrier structure with a quantum well made of a semimagnetic semiconductor. Fabian et al.¹⁵ theoretically analyzed the dependence of the $I - V$ character-

istics of a magnetic $p - n$ junction on the direction of the electron spin with respect to the magnetic field. The phenomena related to the jump of the electron g factor at a semiconductor-vacuum interface have not yet been investigated. In this paper we study the transport of spin-polarized electrons through the p -GaAs(Cs,O)-vacuum interface. The probability of electrons escaping into vacuum was found to depend on the direction of the electron spin with respect to the magnetic field applied perpendicularly to the surface. The experimental results are described well in the emission model which takes into account the jump in the electron g factor at the semiconductor-vacuum interface. The observation of the effect was preliminarily reported in Ref. 16. In this paper we present data and analysis which yield a self-consistent picture of the spin-dependent photoemission at a semiconductor-vacuum interface. The opportunity to explore this effect for studying spin transport in semiconductors is demonstrated. In particular, the spectrum of the observed effect allowed us to determine the spin diffusion length of electrons in p -GaAs.

II. SPIN-DEPENDENT PHOTOEMISSION: A QUALITATIVE EXPLANATION

A phenomenological expression for the spin-dependent component J_S of photocurrent J in a magnetic field \mathbf{H} can be written in the following form:

$$J_S = C(\mathbf{S} \cdot \mathbf{H})J, \quad (1)$$

where \mathbf{S} is the mean spin of optically oriented electrons and the constant C depends on the microscopic mechanism of the effect and determines its relative magnitude. Several microscopic mechanisms of magnetically induced spin-dependent photoemission (SDP) are possible with both bulk and surface origin. Preliminary estimations

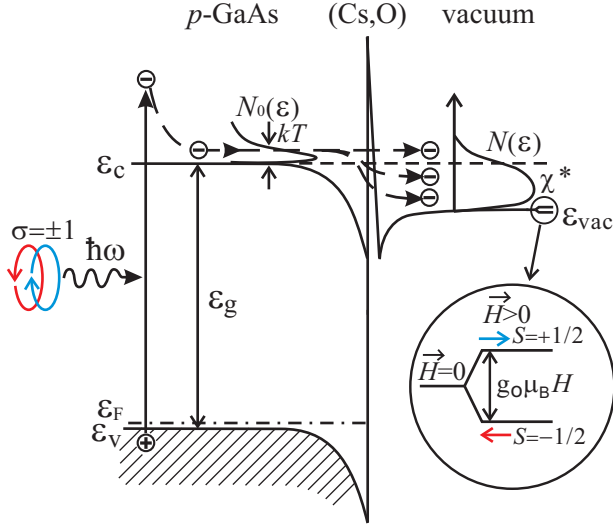


FIG. 1: (Color online) The mechanism of magnetically induced spin-dependent photoemission illustrated on the energy band diagram of NEA-photocathode. The generation of spin-polarized photoelectrons by right ($\sigma = +1$) and left circularly polarized light ($\sigma = -1$), their thermalization to the bottom of the conduction band, diffusion toward the surface, and emission into vacuum are schematically shown. $N_0(\epsilon)$ and $N(\epsilon)$ are the energy distributions of thermalized photoelectrons in the conduction band and of the electrons emitted into vacuum, respectively. The Zeeman splitting of electron states, caused by the external magnetic field, is shown schematically for the vacuum level.

show that for the case of spin-polarized electrons emitted from p -GaAs activated by cesium and oxygen to the state of NEA, a mechanism based on the jump in the g factor at the semiconductor-vacuum interface can significantly contribute to SDP. The jump in the g factor causes the difference between the NEA values for electrons with spins oriented along or opposite to the magnetic field. This difference results in the dependence of the photoemission current on the direction of electron spin with respect to the magnetic field. This mechanism is illustrated on the energy band diagram of the semiconductor-vacuum interface (Fig. 1) and can be explained as follows. The electrons, which are excited in the conduction band by light with photon energies $\hbar\omega$ exceeding the band gap E_g , are thermalized to the band bottom, form a narrow energy distribution with the width of $\approx kT$, diffuse towards the emitting surface, pass through the band bending region, and escape into vacuum. Because of the momentum and energy scattering during electron transport across the band bending region and through the (Cs,O) activation layer^{7,8,9}, in vacuum the kinetic energy distribution of electrons is broadened up to the magnitude of NEA, χ^* , which is defined as the energy difference between the vacuum level and the bottom of the conduction band in the bulk. The electrons, which descend along the energy scale below the vacuum level during thermalization in the band bending region, recombine at

the surface and do not contribute to the photoemission current. Therefore, the photoemission quantum yield, as well as the photocurrent, depends on the value of χ^* .

The external magnetic field causes the Zeeman splitting of electron states. At the bottom of GaAs conduction band the effective g factor is negative $g^* = -0.44$,¹⁷ while in vacuum $g_0 = 2$. As a result, when the direction of the electron spin with respect to the magnetic field changes, the effective electron affinity χ^* changes by $\Delta\chi^* = (g_0 - g^*)\mu_B H$, where $\mu_B = e\hbar/2mc$ is the Bohr magneton and m is the free electron mass. As a result of this change, when spin-polarized electrons are generated in the conduction band by circularly polarized light¹⁸, the photoemission current depends on the degree and sign of the circular polarization.

III. EXPERIMENT

The experiments were carried out in a planar vacuum photodiode consisted of a transmission-mode GaAs(Cs,O) photocathode bonded to a glass substrate and a copper anode. The cathode and anode were hermetically sealed parallel to each other on the opposite ends of an alumina ceramic cylinder. The active p -GaAs layer of the AlGaAs/GaAs heterostructure photocathode was doped by Zn up to $p \approx 5 \times 10^{18} \text{ cm}^{-3}$. The photodiode was placed in a solenoid with the magnetic field perpendicular to the photocathode surface. In our experiments, magnetic fields up to $H = 1$ Tesla were used. All measurements were performed at room temperature. The photoemission current J was measured by illumination of the photocathode through the glass substrate by light from a monochromator with a halogen lamp. The vacuum photodiode can be used as an electron energy analyzer with a uniform retarding electric field.⁸ Specifically, by varying the voltage U applied between the anode and cathode it is possible to collect on the anode all of the emitted electrons (at $U > U_0$), or to collect only part of the emitted electrons with kinetic energies $\epsilon_{\parallel} > U_0 - U$ (at $U < U_0$). Here, U_0 is the voltage that is required to compensate the work function difference and to establish zero electric field in the space between the cathode and anode. The longitudinal kinetic energy is defined as $\epsilon_{\parallel} = p_{\parallel}^2/2m$, where p_{\parallel} is the momentum component parallel to the total photocurrent vector (and perpendicular to the surface).

The spin-dependent component J_S of the photocurrent was measured by a lock-in amplifier as the difference $J_S = J(\sigma^+) - J(\sigma^-)$, where $J(\sigma^+)$ and $J(\sigma^-)$ are the photoemission currents for the excitation by right and left circularly polarized light, respectively. The light polarization was switched between the σ^+ and σ^- states with a frequency of 1.5 kHz by means of a wide-aperture polarization modulator based on the linear electro-optic effect in $\text{Bi}_{12}\text{SiO}_{20}$.¹⁹ The modulation of the polarization of the light beam was accompanied by a parasitic modulation of its intensity with a relative value of about

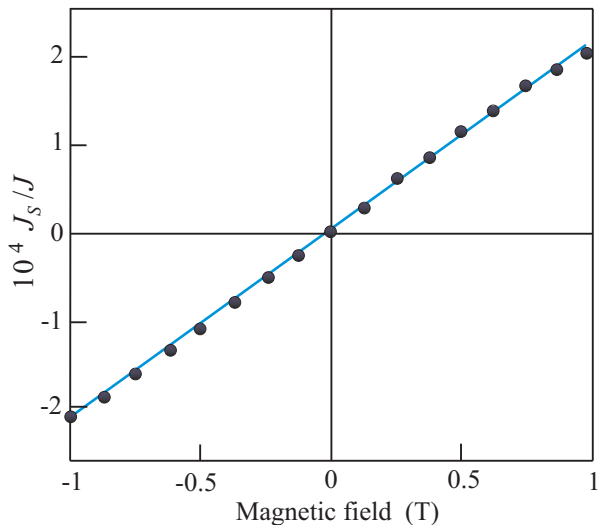


FIG. 2: (Color online) The magnetic field dependence of the polarization-dependent component J_S of the photocurrent normalized to the total photoemission current J . The anode voltage $U = +5$ V, at which all emitted electrons are collected on the anode. The photon energy $\hbar\omega = 1.52$ eV. The parasitic component arising due to modulation of the light intensity is subtracted (see text).

3×10^{-4} . In order to exclude the influence of the intensity modulation on the results of the measurements, we took into account that SDP is an odd function of the magnetic field. To this end, the magnitude of J_S was measured for two opposite directions of the magnetic field $\pm H$, and the value of SDP was determined as $\widetilde{J}_S = [J_S(+H) - J_S(-H)]/2$ (the tilde over J_S will be omitted in the text below). To justify the possibility of using this procedure, the linearity of J_S on the magnetic field was tested. Figure 2 shows a typical magnetic field dependence $J_S(H)$ measured at $\hbar\omega = 1.52$ eV. At this photon energy, SDP caused by the jump in the g factors gives the major contribution to the measured effect (see Fig. 3 and the text below). It is seen that in the investigated range of magnetic fields, J_S is a linear function of the magnetic field, in accordance with phenomenological relation (1) and microscopic mechanism of the effect described in Sec. II. In the text below, basing on the linearity on H , we present experimental data related to the maximal field $H = 1$ T, which yield the highest signal to noise ratio.

IV. RESULTS AND DISCUSSION

In addition to the spin-dependent photoemission caused by the jump in the electron g factor at the semiconductor-vacuum interface, phenomenological equation (1) allows for the existence of bulk effects such as magnetically induced circular dichroism^{20,21} and spin-dependent recombination^{22,23,24} in the bulk of GaAs,

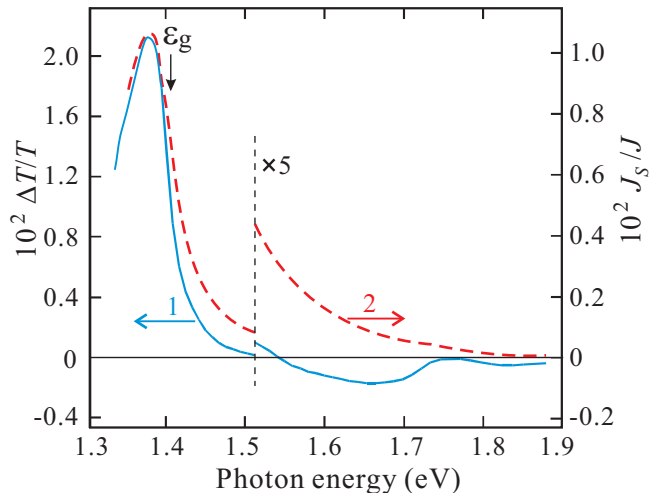


FIG. 3: (Color online) Spectra of circular dichroism $\Delta T/T$ (curve 1, left scale) and spin-dependent photoemission J_S/J (curve 2, right scale). The magnetic field was equal to 1 T.

which may also contribute to the experimentally measured values of J_S . In GaAs, magnetically induced circular dichroism was previously studied for the impurity-related optical transitions below the band gap.²¹ To determine the magnitude of the circular dichroism for the above band gap optical transitions, we measured the relative change in the optical transmission of the GaAs photocathode under the change in the sign of light circular polarization $\Delta T/T = 2[T(\sigma^+) - T(\sigma^-)]/[T(\sigma^+) + T(\sigma^-)]$. Figure 3 shows the spectrum of $\Delta T/T$ measured in the magnetic field $H = 1$ T, as well as the spectrum of J_S/J measured at $H = 1$ T and $U = +5$ V, when all emitted electrons are collected on the anode. From the comparison of the shapes of these two spectra, one can assume that circular dichroism yields the main contribution to SDP for photon energies near the band gap $\hbar\omega \approx 1.4$ eV; however, this is not the fact for $\hbar\omega > 1.5$ eV. It is also seen that for $\hbar\omega = 1.53$ eV and 1.76 eV, dichroism vanishes, while J_S/J is nonzero over the entire spectral range up to $\hbar\omega = 1.8$ eV.

It was not possible to determine the contribution of magnetically induced spin-dependent recombination in the semiconductor bulk. Therefore, in order to extract the surface contribution to the spin-dependent photoemission, the procedure of measuring SDP was modified so that all bulk contributions, including dichroism and spin-dependent recombination in the bulk of GaAs, were subtracted from the measured values of J_S/J . To this end, the magnitude of J_S/J was measured at various voltages U between the anode and cathode in the range of $U_0 - \chi^* < U < U_0$. The lower limit ($U_0 - \chi^*$) corresponds to an almost total cut-off of the photocurrent, when only a small part of electrons emitted into vacuum above the energy of the bottom of the conduction band in the bulk can reach the anode. The upper limit (U_0) corresponds to a complete collection of all photoemit-

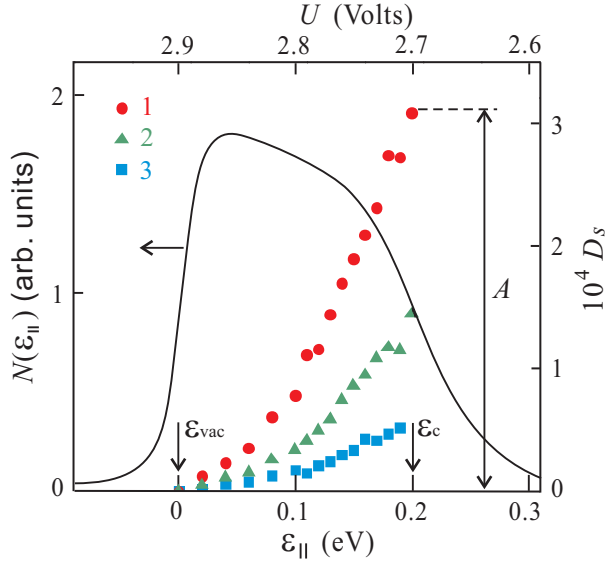


FIG. 4: (Color online) Energy distribution of emitted electrons $N(\epsilon_{||})$ (solid curve, left scale) and voltage dependences of the differential SDP $D_S(U)$ (data points, right scale) measured at $H = 1$ T for various photon energies $\hbar\omega = 1.42$ eV (1), 1.74 eV (2), and 1.82 eV (3). The energies corresponding to the vacuum level ϵ_{vac} and to the bottom of the conduction band ϵ_c are denoted by the vertical arrows.

ted electrons on the anode. To determine the limits of this range experimentally,²⁵ we measured the potential derivative of the photoemission current dJ/dU , which is proportional to the energy distribution function $N(\epsilon_{||})$ of emitted electrons (solid curve in Fig. 4). As seen in Fig. 4, the distribution function $N(\epsilon_{||})$ is bell shaped. The width of $N(\epsilon_{||})$ is equal to the magnitude of NEA;⁸ in our case $\chi^* \approx 0.2$ eV. The lower limit of the voltage range $U = 2.7$ V corresponds to electrons which are emitted from the bottom of the conduction band ϵ_c without momentum and energy scattering with a kinetic energy in vacuum $\epsilon_{||} = \chi^*$. The upper limit $U = U_0 = 2.9$ V corresponds to electrons at the vacuum level ϵ_{vac} . In a previous work,²⁵ we described in detail the procedure for measuring the distribution function of electrons $N(\epsilon_{||})$ as well as for the energy calibration, which makes it possible to determine U_0 and to interlink the voltage scale U with the energy scale $\epsilon_{||}$ and the position ϵ_c of the bottom of the conduction band in the semiconductor bulk.

In order to extract the surface contribution to SDP, we calculated the voltage-dependent part $D_S(U) = [J_S(U)/J(U) - J_S(U_0)/J(U_0)]$ of the spin-dependent photocurrent. By varying the retarding voltage U , we measured the SDP for different groups of electrons which undergo energy and momentum relaxation at the surface and are emitted into vacuum with longitudinal energies below the bottom of the conduction band in the bulk. For a zero surface spin-dependent contribution, the value of J_S/J must be the same for different groups of scattered electrons. Therefore, the voltage-dependent part of SDP

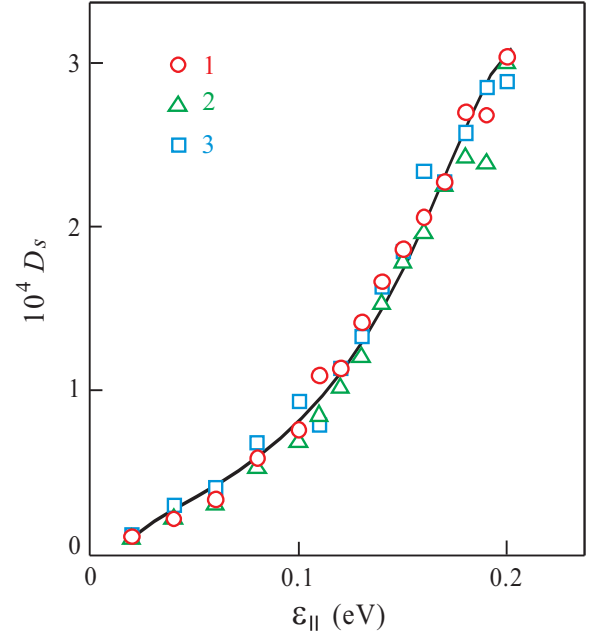


FIG. 5: (Color online) Differential SDP (data points) measured at various photon energies $\hbar\omega = 1.42$ eV (1), 1.74 eV (2), and 1.82 eV (3). Dependences (2) and (3) are multiplied by the factors of 2.1 and 5.6, respectively, in order to scale with (1). The solid line is the approximation of the measured dependences by formula (2).

can be assigned to only the surface contribution because bulk contributions do not depend on U .

The data points in Fig. 4 show the dependence $D_S(U)$ measured at various photon energies $\hbar\omega$. It is seen that at each $\hbar\omega$ the differential spin-dependent photocurrent is maximal for electrons emitted from the bottom of the conduction band and monotonically goes down with increasing U , that is, with decreasing electron kinetic energy. It is also seen from Fig. 4 that the amplitude A of variations in D_S decreases with increasing photon energy, while the shapes of the dependences $D_S(U)$ are similar. Figure 5 shows the scaled dependences $D_S(U)$ measured at various $\hbar\omega$. The scaling factors were fitted to minimize the difference between the measured dependences. It is seen that the shapes of all three dependences $D_S(U)$ coincide with each other within the experimental accuracy. Thus, the shape of the energy dependence $D_S(U)$ is indeed independent of the photon energy.

We compared the universal shape of the measured dependences $D_S(U)$ to the calculation in the model of magnetically induced spin-dependent photoemission arising due to the jump in the g factor at the GaAs(Cs,O)-vacuum interface. In this model the effective NEA and, consequently, the width of the energy distribution function of spin-polarized electrons vary by $\Delta\chi^* = (g_0 - g^*)\mu_B H$ when the direction of the electron spin changes with respect to the magnetic field. The respective change in the current created by photoelectrons with mean spin

S is equal to $J_S = S\Delta\chi^*N(U)$. Thus, the voltage-dependent component of SDP can be expressed as follows:

$$D_S(U) = S\Delta\chi^* \frac{N[\varepsilon(U)]}{J(U)} - D_0. \quad (2)$$

This calculated dependence $D_S(U)$, which approximates the experimental dependences, is shown by the solid line in Fig. 5. For the calculation, we used the experimentally measured energy distribution function $N(\varepsilon_{||})$ and the voltage dependence of the photoemission current $J(U)$ obtained by numerically integrating this distribution. Taking into account a finite resolution $\Delta\varepsilon_{||} = 20$ meV of the measurements of the energy distribution function $N(\varepsilon_{||})$, Eq. (2) is valid for voltages $U < U_0 - \Delta\varepsilon_{||}$. The value of the mean spin of photoemitted electrons was determined in the diffusion model²⁶ from the spectral dependence of SDP amplitude (see Fig. 6). The value of the electron affinity modulation $\Delta\chi^*$, which determines the amplitude A of variations in SDP with varying U , was a fitting parameter and found to be equal to 0.09 meV. The constant $D_0 \approx 10^{-4}$ was determined so that the calculated value of D_S coincides with the experimental value for $U = U_0 - \Delta\varepsilon_{||}$. It is seen that the shape of the calculated dependence $D_S(U)$ describes the experiment well. The fitting parameter $\Delta\chi^* = 0.09$ meV should be compared with $\Delta\chi^* = 0.14$ meV estimated from the known value $g^* = -0.44$ of the electron g factor on the bottom of the conduction band of GaAs. The agreement between the experimental and calculated values of $\Delta\chi^*$ may be considered as reasonably good, keeping in mind that photoelectrons acquire kinetic energy in the band bending region before emission, and this alters the effective g factor due to its energy dependence.²⁷ Moreover, according to Refs. 2,28,29, in a semiconductor with the state of NEA, the photoemission occurs via electron capture to a two-dimensional sub-band in the band bending region and subsequent elastic or inelastic tunneling into vacuum through the potential barrier formed by the (Cs,O) layer. Therefore, the effective g factor may be changed by the electron quantization,^{30,31,32} as well as by the atomic structure of the GaAs(Cs,O) interface. The magnitude and energy dependence of SDP are also possibly influenced by the partial relaxation of the spin of electrons passing through the GaAs(Cs,O)-vacuum interface.¹⁰ It is worth noting that along with the jump in the g factor, a microscopic cause of the SDP at the surface may consist of spin-dependent recombination of photoelectrons on paramagnetic surface centers oriented by the magnetic field.³³ However, spin-dependent recombination likely did not play a significant role in our experiment performed at room temperature.

The effect of spin-dependent photoemission can be used as a method for determining the spin diffusion length L_S of electrons in semiconductors. The idea of this method can be explained as follows. Under photocathode illumination the spatial distribution of generated photoelectrons depends on the photon energy in accor-

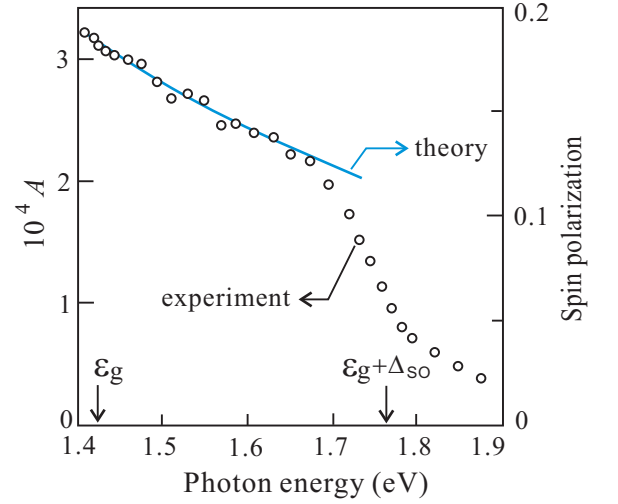


FIG. 6: (Color online) The spectra of the experimentally measured amplitude A of the surface contribution to SDP (data points, left scale) and of the calculated degree of spin polarization of photoemitted electrons (solid line, right scale). The amplitude of SDP, A , was determined as $D_S(\varepsilon_c)$ (see Fig. 4).

dance with the spectral dependence of the light absorption coefficient $\alpha(\hbar\omega)$. Therefore, the photons with various energies $\hbar\omega$ generate electrons at various distances from the emitting surface. Due to electron spin relaxation in the course of the diffusion toward the emitting surface, the mean spin of emitted electrons S depends on $\hbar\omega$. As the amplitude A of the surface contribution to SDP is proportional to S , this leads to the spectral dependence of $A = A(\hbar\omega)$. The shape of this dependence is determined by the spin diffusion length of electrons.

The measured spectrum of $A(\hbar\omega)$ is shown in Fig. 6 by dots (left scale). It is seen that the amplitude of SDP decreases with increasing $\hbar\omega$. The abrupt drop in A near $\hbar\omega = \varepsilon_g + \Delta_{so} \approx 1.76$ eV is due to the onset of optical interband transitions from the spin-orbit split valence band because these transitions generate electrons with spin opposite to the mean spin of electrons excited by near-band-gap optical transitions.¹⁸ The gradual decrease in the SDP amplitude A at photon energies $\varepsilon_g < \hbar\omega < \varepsilon_g + \Delta_{so}$ is due to the dependence of the initial polarization of photogenerated electrons on $\hbar\omega$ (Ref. 18) and also due to spin relaxation of electrons during the diffusion towards the emitting surface.

In order to determine the spin diffusion length and the degree of spin polarization of photoemitted electrons, we compared the experimental dependence $A(\hbar\omega)$ with the spectral dependence of the electron spin polarization calculated in the diffusion model²⁶ in the spectral range of $\varepsilon_g < \hbar\omega < \varepsilon_g + \Delta_{so}$. The spectral dependence of the initial polarization of photogenerated electrons and spin depolarization in the process of diffusion toward the emitting surface were taken into account. The theoretical dependence is shown in Fig. 6 by the solid curve (the right scale). The following parameters of the AlGaAs/GaAs

photocathode heterostructure were used for the calculation: the thickness of the active p -GaAs layer, $d = 1.2 \mu\text{m}$; the electron diffusion length in the active layer, $L_e = 3.5 \mu\text{m}$; the recombination velocity between the p -GaAs and buffer AlGaAs layers, $V_{S1} = 10^4 \text{ cm/s}$; and the effective recombination velocity at the emitting surface, $V_{S2} = 10^7 \text{ cm/s}$. The spin diffusion length L_S was a fitting parameter. As the electron diffusion length $L_e > d$ and $V_{S1} \ll V_{S2}$, the variations of the parameters L_e (at $L_e > 3 \mu\text{m}$), V_{S1} (from 10^4 to $5 \times 10^5 \text{ cm/s}$), and V_{S2} (in the range of $3 \times 10^6 - 10^7 \text{ cm/s}$) do not lead to significant changes in the calculated curve. The best fit value of the spin diffusion length was equal to $L_S = 0.45 \pm 0.05 \mu\text{m}$. The corresponding value of the spin polarization of photoemitted electrons generated by photons with energies near the band gap $\hbar\omega \approx \varepsilon_g$ is equal to $S = 0.20 \pm 0.02$. The obtained value of the spin diffusion length is in good agreement with $L_S = 0.55 \mu\text{m}$ reported by Dzhioev et al.²⁶ The authors of Ref. 26 studied spin polarization by the photoluminescence technique in a glass-bonded photocathode structure similar to that used in our photoemission experiment, with about the same value of doping level in the active p -GaAs layer.

V. CONCLUSIONS

Thus, it is experimentally found that in an external magnetic field the probability of electron emission from

GaAs with the state of NEA into vacuum depends on the orientation of electron spin with respect to the direction of the field. This phenomenon stems from the jump in the electron g factor on the semiconductor-vacuum interface. Due to this jump, the effective electron affinity of a photocathode depends on the mutual directions of the electron spin and magnetic field. This mechanism successfully describes the magnitude and energy dependence of SDP. A comparison of the measured and calculated spectra of the spin-dependent photoemission enabled us to determine the spin diffusion length in p -GaAs and spin polarization of photoemitted electrons.

Acknowledgments

This work was supported by the Russian Academy of Sciences (program "Spin-dependent phenomena and spintronics") and by the Russian Foundation for Basic Research (Grant No. 07-02-01005).

-
- * Electronic address: alper@thermo.isp.nsc.ru
- ¹ *Semiconductor Spintronics and Quantum Computation*, edited by D.D. Awschalom, D. Loss, and N. Samarth (Springer, Berlin, 2002).
 - ² R. L. Bell, *Negative Electron Affinity Devices* (Clarendon, Oxford, 1973).
 - ³ C. Cacho, Y. Lassailly, H.-J. Drouhin, G. Lampel, and J. Peretti, Phys. Rev. Lett. **88**, 066601 (2002).
 - ⁴ V. L. Alperovich, A. S. Terekhov, A. S. Jaroshevich, G. Lampel, Y. Lassailly, J. Peretti, N. Rougemaille, and T. Wirth, Nucl. Instrum. Methods Phys. Res. A **536**, 302 (2005).
 - ⁵ D. T. Pierce, R. J. Celotta, G.-G. Wang, W. N. Unertl, A. Galejs, C. E. Kuyatt, and S. R. Mielczarek, Rev. Sci. Instrum. **51**, 478 (1980).
 - ⁶ R. Prepost and T. Maruyama, Annu. Rev. Nucl. Part. Sci. **45**, 41 (1995).
 - ⁷ H.-J. Drouhin, C. Hermann, and G. Lampel, Phys. Rev. B **31**, 3859 (1985).
 - ⁸ A. S. Terekhov and D. A. Orlov, JETP Lett. **59**, 864 (1994).
 - ⁹ D. A. Orlov, M. Hoppe, U. Weigel, D. Schwalm, A. S. Terekhov, and A. Wolf, Appl. Phys. Lett. **78**, 2721 (2001).
 - ¹⁰ H.-J. Drouhin, C. Hermann, and G. Lampel, Phys. Rev. B **31**, 3872 (1985).
 - ¹¹ A. Voskoboynikov, S. S. Liu, and C. P. Lee, Phys. Rev. B **58**, 15397 (1998).
 - ¹² V. I. Perel', S. A. Tarasenko, I. N. Yassievich, S. D. Ganichev, V. V. Bel'kov, and W. Prettl, Phys. Rev. B **67**, 201304(R) (2003).
 - ¹³ S. A. Tarasenko, V. I. Perel', and I. N. Yassievich, Phys. Rev. Lett. **93**, 056601 (2004).
 - ¹⁴ T. Gruber, M. Keim, R. Fiederling, G. Reuscher, W. Ossau, G. Schmidt, L. W. Molenkamp, and A. Waag, Appl. Phys. Lett. **78**, 1101 (2001).
 - ¹⁵ J. Fabian, I. Žutić, and S. Das Sarma, Phys. Rev. B **66**, 165301 (2002).
 - ¹⁶ D. A. Orlov, V. L. Alperovich, and A. S. Terekhov, JETP Lett. **83**, 453 (2006).
 - ¹⁷ C. Weisbuch and C. Hermann, Phys. Rev. B **15**, 816 (1977).
 - ¹⁸ *Optical Orientation*, Modern Problems in Condensed Matter Sciences Vol. 8, edited by F. Meier and B. P. Zakharchenya (North-Holland, Amsterdam, 1984/Nauka, Leningrad, 1989).
 - ¹⁹ V. L. Alperovich, A. O. Minaev, S. P. Moshchenko, and A. S. Terekhov, Opt. Spectrosc. **65**, 798 (1988).
 - ²⁰ R. P. Seisyan, *Spectroscopy of Diamagnetic Excitons* (Nauka, Moscow, 1984).
 - ²¹ U. Kaufmann and J. Windscheif, Phys. Rev. B **38**, 10060 (1988).
 - ²² I. Solomon, J. Non-Cryst. Solids **35-36**, 625 (1980).
 - ²³ C. Weisbuch and G. Lampel, Solid State Commun. **14**, 141 (1974).
 - ²⁴ D. Paget, Phys. Rev. B **30**, 931 (1984).

- ²⁵ A.S. Terekhov and D.A. Orlov, SPIE Proc. **2550**, 157 (1995).
- ²⁶ R.I. Dzhioev, B.P. Zakharchenya, R.R. Ichkitidze, K.V. Kavokin, and P.E. Pak, Fiz. Tverd. Tela **35**, 2821 (1993).
- ²⁷ P. Pfeffer and W. Zawadzki, Phys. Rev. B **41**, 1561 (1990).
- ²⁸ V.L. Korotkikh, A.L. Musatov, and V.D. Shadrin, JETP Lett. **27**, 616 (1978).
- ²⁹ D.A. Orlov, V.E. Andreev, and A.S. Terekhov, JETP Lett. **71**, 151 (2000).
- ³⁰ E.L. Ivchenko and A.A. Kiselev, Sov. Phys. Semicond. **26**, 827 (1992).
- ³¹ A.A. Kiselev, E.L. Ivchenko, and U. Rössler, Phys. Rev. B **58**, 16353 (1998).
- ³² P. Pfeffer and W. Zawadzki, Phys. Rev. B **74**, 115309 (2006).
- ³³ D. Lepine, Phys. Rev. B **6**, 436 (1972).